

**Search Notes**

Application/Control No.

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Examiner

Binh X. Tran

Applicant(s)/Patent under  
Reexamination

KAWAGUCHI ET AL.

Art Unit

1765

**SEARCHED**

Class	Subclass	Date	Examiner
216	68	10/4/2007	BT
216	69	10/04/2007	BT
216	73	10/4/2007	BT
438	715	10/4/2007	BT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Updated search using database in EAST	10/4/2007	BT